Notice of References Cited Application/Control No. 10/602,506 Examiner Benjamin C. Lee Applicant(s)/Patent Under Reexamination HANABUSA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,602,718	08-2003	Augello et al.	436/176	
	В	US-			<u> </u>	
	С	US-				
	D	US-			·	
	Е	US-				
	F	US-				
	G	US-				
	Н	US-	(L)			
	ı	US-				
	J	US-				
	К	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
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NON-PATENT DOCUMENTS

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